# IRLZ14S, SiHLZ14S

**Vishay Siliconix** 



D<sup>2</sup>PAK (TO-263)

**PRODUCT SUMMARY** 

V<sub>DS</sub> (V)

R<sub>DS(on)</sub> (Ω)

Q<sub>qs</sub> (nC)

Q<sub>gd</sub> (nC)

Q<sub>q</sub> max. (nC)

Configuration

# Power MOSFET

### **FEATURES**

- Advanced process technology
- Surface-mount
- 175 °C operating temperature
- Fast switching
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

#### Note

S

N-Channel MOSFET

0.20

60

8.4

3.5

6.0

Single

 $V_{GS} = 5 V$ 

This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

### DESCRIPTION

Third generation power MOSFETs from Vishay utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that power MOSFETs are well known for, provides the designer with an extremely efficient reliable device for use in a wide variety of applications.

The D<sup>2</sup>PAK (TO-263) is a surface-mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and lowest possible on-resistance in any existing surface-mount package. The D<sup>2</sup>PAK (TO-263) is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface-mount application.

ORDERING INFORMATION					
Package	D <sup>2</sup> PAK (TO-263)	D <sup>2</sup> PAK (TO-263)	D <sup>2</sup> PAK (TO-263)		
Lead (Pb)-free and halogen-free	SiHLZ14S-GE3	SiHLZ14STRL-GE3 <sup>a</sup>	SiHLZ14STRR-GE3 <sup>a</sup>		
Lead (Pb)-free	IRLZ14SPbF	IRLZ14STRLPbF <sup>a</sup>	IRLZ14STRRPbF <sup>a</sup>		

Note See device orientation

PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-source voltage <sup>e</sup>	V <sub>DS</sub>	60	N			
Gate-source voltage	V <sub>GS</sub>	± 10	V			
Continuous drain current	V at E V	$T_C = 25 \text{ °C}$ $T_C = 100 \text{ °C}$		10		
Continuous drain current	$V_{GS}$ at 5 V	T <sub>C</sub> = 100 °C	ID	7.2	А	
Pulsed drain current <sup>a, e</sup>		I <sub>DM</sub>	40			
Linear derating factor			0.29	W/°C		
Single pulse avalanche energy <sup>b, e</sup>			E <sub>AS</sub>	68	mJ	
Maximum maximum disaination	T <sub>C</sub> =	25 °C	P	43		
Maximum power dissipation	T <sub>A</sub> = 25 °C		P <sub>D</sub>	3.7	W	
Peak diode recovery dv/dt c, e	dv/dt	4.5	V/ns			
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C		
Soldering recommendations (peak temperature) d	nperature) <sup>d</sup> For 10 s			300		

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

 $V_{DD}$  = 25 V, starting T<sub>J</sub> = 25 °C, L = 790 µH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 10 A (see fig. 12) I<sub>SD</sub> ≤ 10 A, di/dt ≤ 90 A/µs, V<sub>DD</sub> ≤ V<sub>DS</sub>, T<sub>J</sub> ≤ 175 °C 1.6 mm from case b.

c. d.

Uses IRLZ14, SiHLZ14 data and test conditions e.

S20-0684-Rev. D, 07-Sep-2020

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HALOGEN FREE

# IRLZ14S, SiHLZ14S



Vishay Siliconix

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum junction-to-ambient (PCB mount) <sup>a</sup>	R <sub>thJA</sub>	-	40	°C/W		
Maximum junction-to- case (drain)	R <sub>thJC</sub>	-	3.5			

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static				•		•	
Drain-source breakdown voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0, I <sub>D</sub> = 250 μA		60	-	-	V
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.07	-	V/°C
Gate-source threshold voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	- V <sub>GS</sub> , I <sub>D</sub> = 250 μΑ	1.0	-	2.0	V
Gate-source leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 10 V	-	-	± 100	nA
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub>	= 60 V, V <sub>GS</sub> = 0 V	-	-	25	
		V <sub>DS</sub> = 48 V	, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C	-	-	250	μA
Drain actures en state registernes	D	$V_{GS} = 5 V$	I <sub>D</sub> = 6.0 A <sup>b</sup>	-	-	0.2	
Drain-source on-state resistance	R <sub>DS(on)</sub>	$V_{GS} = 4 V$	I <sub>D</sub> = 5.0 A <sup>b</sup>	-	-	0.28	Ω
Forward transconductance	g <sub>fs</sub>	V <sub>DS</sub>	= 25 V, I <sub>D</sub> = 6.0 A	3.5	-	-	S
Dynamic				•		•	
Input capacitance	C <sub>iss</sub>	$V_{GS} = 0 V$ ,		-	400	-	pF
Output capacitance	C <sub>oss</sub>		$V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5		170	-	
Reverse transfer capacitance	C <sub>rss</sub>	f = 1			42	-	
Total gate charge	Qg			-	-	8.4	nC
Gate-source charge	Q <sub>gs</sub>	$V_{GS} = 5 V$	$V_{GS} = 5 V$ $I_D = 10 A, V_{DS} = 48 V,$ see fig. 6 and 13 <sup>b</sup>		-	3.5	
Gate-drain charge	Q <sub>gd</sub>		see lig. o and to	-	-	6.0	1
Turn-on delay time	t <sub>d(on)</sub>			-	9.3	-	
Rise time	t <sub>r</sub>	V <sub>DD</sub>	= 30 V, I <sub>D</sub> = 10 A,	-	110	-	1
Turn-off delay time	t <sub>d(off)</sub>	R <sub>g</sub> = 12 Ω,	$R_D$ = 2.8 $\Omega$ , see fig. 10 <sup>b</sup>	-	17	-	ns
Fall time	t <sub>f</sub>			-	26	-	1
Internal source inductance	L <sub>S</sub>	Between lead	, and center of die contact	-	7.5	-	nH
Drain-Source Body Diode Characteristic	cs	<u>.</u>					
Continuous source-drain diode current	I <sub>S</sub>	showing the	MOSFET symbol showing the		-	10	_
Pulsed diode forward current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	40	A
Body diode voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C	, I <sub>S</sub> = 10 A, V <sub>GS</sub> = 0 V <sup>b</sup>	-	-	1.6	V
Body diode reverse recovery time	t <sub>rr</sub>	T 05 00 1		-	93	130	ns
Body diode reverse recovery charge	Q <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}^{\text{b}}$		-	340	650	nC
Forward turn-on time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )					L <sub>D</sub> )

### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b. Pulse width  $\leq$  300  $\mu s;$  duty cycle  $\leq$  2  $\,\%$ 



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

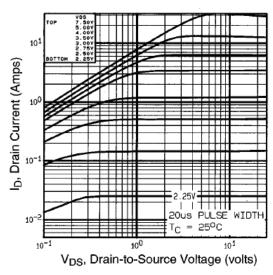


Fig. 1 - Typical Output Characteristics

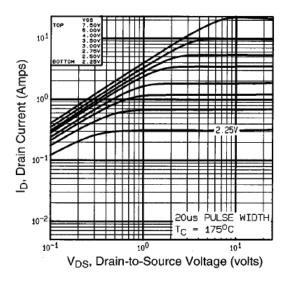


Fig. 2 - Typical Output Characteristics

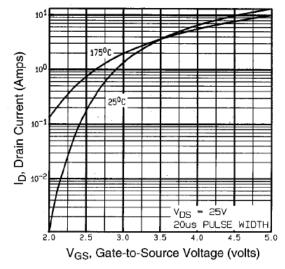


Fig. 3 - Typical Transfer Characteristics

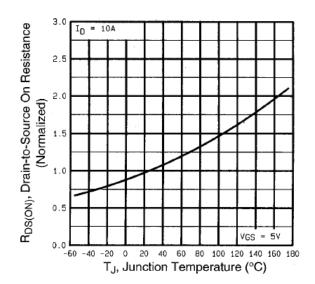


Fig. 4 - Normalized On-Resistance vs. Temperature



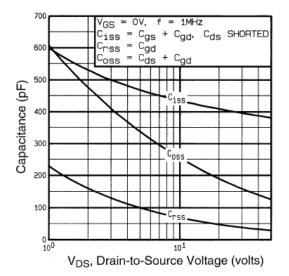


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

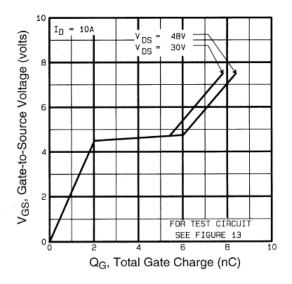


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



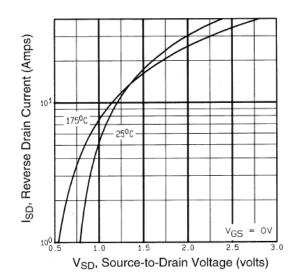


Fig. 7 - Typical Source-Drain Diode Forward Voltage

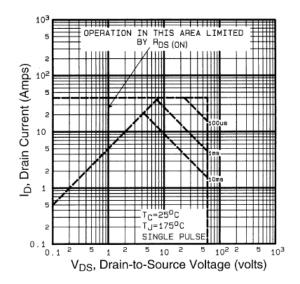
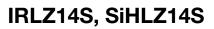


Fig. 8 - Maximum Safe Operating Area





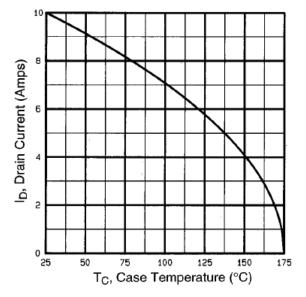


Fig. 9 - Maximum Drain Current vs. Case Temperature

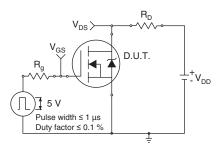


Fig. 10a - Switching Time Test Circuit

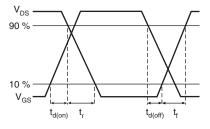
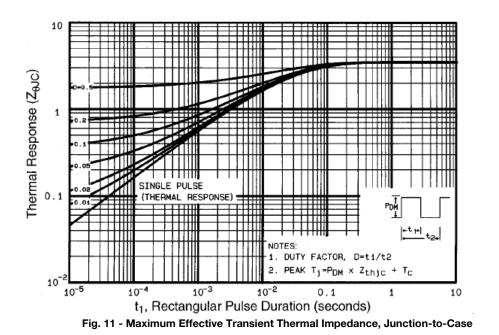


Fig. 10b - Switching Time Waveforms





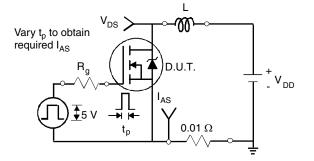


Fig. 12a - Unclamped Inductive Test Circuit

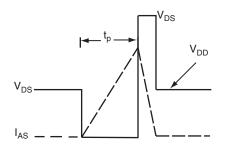


Fig. 12b - Unclamped Inductive Waveforms

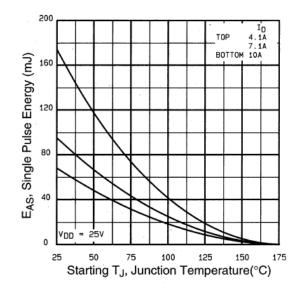


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

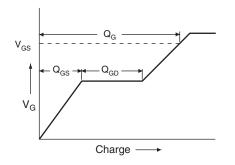


Fig. 13a - Basic Gate Charge Waveform

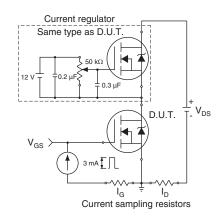
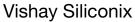


Fig. 13b - Gate Charge Test Circuit

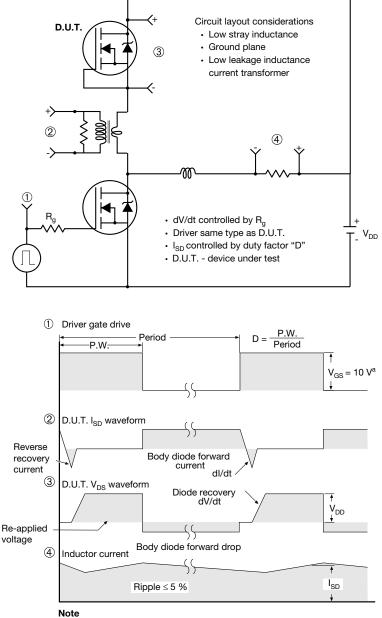
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# IRLZ14S, SiHLZ14S





### Peak Diode Recovery dV/dt Test Circuit



a.  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="http://www.vishay.com/ppg?90414">www.vishay.com/ppg?90414</a>.

## **TO-263AB (HIGH VOLTAGE)**

/3

ВH B 4

A

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∕₅∖

Detail A

(Datum A)

D

 $\underline{4}$ 11

				$c \rightarrow \bullet$ $\pm 0.004 \textcircled{0} B$ Base $d \rightarrow d \rightarrow$							
	MILLIN	<b>IETERS</b>	INC	HES			MILLIN	<b>IETERS</b>	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.		DIM.	MIN.	MAX.	MIN.	MA	
А	4.06	4.83	0.160	0.190		D1	6.86	-	0.270	-	
A1	0.00	0.25	0.000	0.010		E	9.65	10.67	0.380	0.4	
b	0.51	0.99	0.020	0.039		E1	6.22	-	0.245	-	
b1	0.51	0.89	0.020	0.035		е	2.54	BSC	0.100	) BSC	
b2	1.14	1.78	0.045	0.070		Н	14.61	15.88	0.575	0.6	
b3	1.14	1.73	0.045	0.068		L	1.78	2.79	0.070	0.1	
С	0.38	0.74	0.015	0.029		L1	-	1.65	-	0.0	
c1	0.38	0.58	0.015	0.023		L2	-	1.78	-	0.0	
c2	1.14	1.65	0.045	0.065		L3	0.25	BSC	0.010	) BSC	

Α

ECN: S-82110-Rev. A, 15-Sep-08 DWG: 5970

8.38

Notes

D

9.65

0.330

0.380

2. Dimensions are shown in millimeters (inches).

3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.

L4

5.28

0.188

4.78

4. Thermal PAD contour optional within dimension E, L1, D1 and E1.

- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.



H

A1

B

Gauge plane 0° tọ 8°

L3

Detail "A" Rotated 90° CW

coolo 9.1

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Seating plane

MAX.

0.420

-

0.625

0.110 0.066

0.070

0.208

<sup>1.</sup> Dimensioning and tolerancing per ASME Y14.5M-1994.

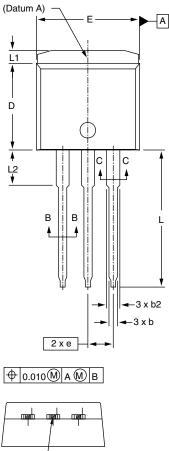


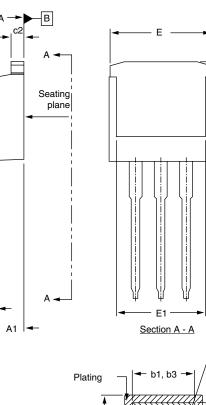
D1

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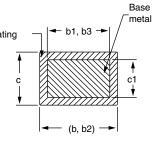


## I<sup>2</sup>PAK (TO-262) (HIGH VOLTAGE)





T	ead	tin



Scale: None

	MILLIN	IETERS	INC	HES				
DIM.	MIN.	MAX.	MIN.	MAX.				
А	4.06	4.83	0.160	0.190				
A1	2.03	3.02	0.080	0.119				
b	0.51	0.99	0.020	0.039				
b1	0.51	0.89	0.020	0.035				
b2	1.14	1.78	0.045	0.070				
b3	1.14	1.73	0.045	0.068				
с	0.38	0.74	0.015	0.029				
c1	0.38	0.58	0.015	0.023				
c2	1.14	1.65	0.045	0.065				
	ECN: S-82442-Rev. A, 27-Oct-08 DWG: 5977							

	MILLIN	<b>IETERS</b>	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
D	8.38	9.65	0.330	0.380	
D1	6.86	-	0.270	-	
Е	9.65	10.67	0.380	0.420	
E1	6.22	-	0.245	-	
е	2.54	BSC	0.100 BSC		
L	13.46	14.10	0.530	0.555	
L1	-	1.65	-	0.065	
L2	3.56	3.71	0.140	0.146	

Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outmost extremes of the plastic body.

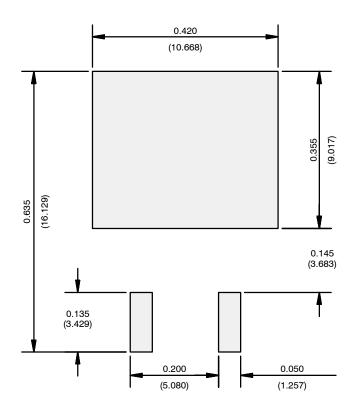
c →||-

3. Thermal pad contour optional within dimension E, L1, D1, and E1.

4. Dimension b1 and c1 apply to base metal only.



## **RECOMMENDED MINIMUM PADS FOR D<sup>2</sup>PAK: 3-Lead**



Recommended Minimum Pads Dimensions in Inches/(mm)

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